

Claims

1. A system for integrated circuit design comprising:

a high level design comprising a chip architecture, a floor plan, and one or more critical interconnect wire topologies;

5 a schematic design comprising one or more circuit components and one or more critical interconnect wire models;

a physical layout comprising said one or more circuit components and said one or more critical interconnect wire topologies;

extracted parameters of said one or more circuit components and calculated parameters of said critical interconnect wire models; and

calculated parameters of said critical interconnect wire models; and

results of a simulation of a schematic design comprising said extracted parameters and said calculated parameters.

2. An integrated circuit design kit comprising:

one or more circuit components topologies; and

one or more critical interconnect lines topologies.

3. The kit of claim 2 wherein said interconnect line topologies are predefined.

20 4. The kit of claim 2 and further comprising one or more circuit components models.

5. The kit of claim 2 and further comprising one or more critical interconnect lines models.

6. A topology of critical interconnect lines.

5

7. The topology of claim 6 wherein said topology is predefined.

8. The topology of claim 6 comprising a definite current return path.

10 9. The topology of claim 6 wherein said topology is supplemented by a model comprising one or more of said following electrical parameters: capacitance, low frequency inductance, high frequency inductance, low frequency series resistance, high frequency series resistance, TEM impedance, and matrix representations of one or more of said parameters.

15 10. The topology of claim 6 wherein said sum of said currents of a cross section of said topology is zero.

20 11. The topology of claim 6 wherein said topology comprises one or more signal wires and one or more shielding wires.

12. The topology of claim 11 wherein said one or more shielding wires is one or more side shielding wires located on one or more sides of said signal wires.

13. The topology of claim 11 and wherein said one or more shielding wires is a bottom shielding wire.

5 14. The topology of claim 11 and wherein said one or more shielding wires is one or more shielding layers.

15. A computer software product for designing an integrated circuit, said product comprising a computer readable medium in which program instruction are stored, which instructions, when read by a computer, cause said computer to create a topology of critical interconnect lines.

16. The product of claim 15 and further comprising instructions, which instructions, when read by a computer, cause said computer to create a model of critical interconnect lines.

17. A computer software product for designing an integrated circuit, said product comprising a computer readable medium in which program instruction are stored, which instructions, when read by a computer, cause said computer to create a design kit comprising a topology of critical interconnect lines.

20

18. The product of claim 17 and further comprising instructions, which instructions, when read by a computer, cause said computer to create a model of critical interconnect lines.

5 19. A method for designing integrated circuits (IC), said method comprising the steps of:

- (a) defining a chip architecture and a floor plan;
- (b) identifying one or more critical interconnect lines, and defining transmission line topologies for design of said critical interconnect lines;
- (c) determining a schematic design of said IC;
- (d) defining a physical layout of said IC;
- (e) extracting electrical parameters of said layout;
- (f) simulating said schematic design; and
- (g) receiving results of said simulation.

20. The method of claim 19 and further comprising:

- (h) comparing said simulation results to a set of initial design requirements.

21. The method of claim 20 and further comprising:

20 according to results of said step (h), repeating steps (d) to (g)

22. The method of claim 19, wherein said integrated circuits are analog and mixed signal (AMS) circuits or application specific integrated circuits (ASIC).

23. The method of claim 19, wherein in (b), the step of defining comprises choosing from a set of predefined parameterized topologies.

5 24. The method of claim 19, wherein in (b), the step of defining comprises defining a set of topologies.

25. The method according to claim 19, wherein said schematic design comprises models of said one or more transmission line topologies.

10

26. The method according to claim 25, and further comprising the step of calculating one or more electrical parameters of said models.

15

27. The method according to claim 26, wherein said one or more electrical parameters includes one or more of the following: capacitance, low frequency inductance, high frequency inductance, low frequency series resistance, high frequency series resistance, TEM impedance, and matrix representations of one or more of said parameters.

20 28. The method according to claim 19, wherein step (b) comprises: using one or more of said following to identify said critical interconnect lines: estimated length, metal level assignment and manual user selection.

29. The method according to claim 19, and further comprising creating parameterized cells from said models.

30. A method for designing integrated circuits wherein defining said chip
5 architecture and a floor plan comprises defining critical interconnect wires.